

Notice of References Cited		Application/Control No. 10/043,465	Applicant(s)/Patent Under Reexamination GERLACH ET AL.	
		Examiner Roy D. Gibson	Art Unit 3739	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,327,278	12-2001	Toscheck et al.	372/6
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Data Sheets for 532 nm Lasers by JDS Uniphase Company.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.